

## **VIS 1700**

### Voltage interruption simulator

### IEC / EN 61000-4-11 (AC), IEC / EN 61000-4-29 (DC)

- Automatic AC + DC ramp function (voltage fluctuations, 2. voltage source not necessary)
- Inrush current measurement at any phase position 0° - 360



#### 4 operating modes possible:

short time interruption, voltage dip/fluctuation, inrush current measurement



The VIS 1700 simulator can simulate the voltage dips and fluctuations occurring on the supply networks (AC and DC). Different operating modes are possible:

#### Short time interruptions 100 %:

Interruption of the supply voltage from the EUT from 100 % to 0 %. The supply network of the EUT can be interrupted in any phase position for a defined time (0.1 ms - 9980 ms). Rise and fall time:  $1 - 5 \mu s$ .

#### Voltage dips with external step transformer:

Reduction of the supply voltage from the EUT from 100 % to X %. Dips to 40 %, 70 % or 80 % of the nominal voltage can be simulated at a certain phase angle and a time x. This test requires a 2nd voltage source, which a step transformer with sufficient power fulfills - see option - accessory VIS 740. Rise and fall time: 1 -  $5~\mu s$ 

# Voltage fluctuations with automatic ramp function (variation function):

Internal reduction of the supply voltage with adjustable ramps and adjustable test time. Fluctuation to an adjustable voltage (0 - 95 % of U1). The parameters for fall time, test time and recovery time (0.1 to 70 sec. each) can be set individually. For this purpose, it is not necessary to feed in a further voltage.

#### Inrush current measurement:

The inrush current can be measured at any phase position (0 - 360°) for each test object up to a maximum of 16 A rated current (AC).

#### **Key Facts**

- For monitoring, three BNC sockets for the parameters voltage, current and trigger are provided at the rear
  of the device
- A step transformer is required for voltage dips (see Options: VIS 740)
- Clearly arranged display





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## Technical data

VIS 1700	
EUT supply	
Rated voltage and currer	nts
Short time interruption	
AC	max. 280 V / 16 A
DC	max. 360 V / 8 A
Voltage dips	(with external step
	transformer)
AC	max. 280 V / 16 A
DC	max. 360 V / 8 A
Voltage fluctuation	(with automatic ramp
	function!)
AC	max. 280 V / 16 A
DC	max. 360 V / 4 A
Phase angle	φ = 0 - 359°, step 1°
Duration t1	0,1 ms - 9980 ms
Period t2	asynchronous:
	5,0 ms - 9990 ms
	sync:
	20 ms - 9980 ms
Test time	0,1 sec - 9990 sec, single
	event and duration

Interface	RS-232
Connections	BNC (voltage, current
	and trigger)
Test sample connection	Schuko socket
	additional laboratory
	sockets
Phase display	LED red
	LED green
Operating temperature	0 - 40° C
Dimensions	19" housing
	(3 RU)
Weight	13 kg
Supply voltage	100 - 240 V / 47-63 Hz /
	80 VA

### Technical data – Standard requirements

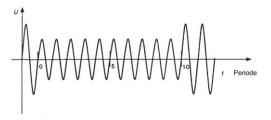


Fig. 1: Voltage dips, here 10 periods to 70%

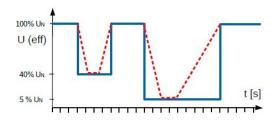


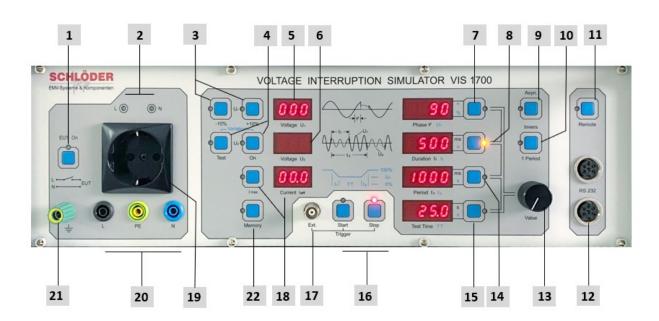
Fig. 2: Voltage fluctuations



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#### **Technical data: Functions**



[1]	EUT on / off
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[2] Phase indication: LED red, LED red

[3] Supply voltage  $U_1 = U_N$ switchable to +10 %  $U_N$  and - 10 %  $U_N$ 

[4] Def. of the 2nd voltage U<sub>2</sub>-test and U<sub>2</sub>-On and activation of the ramp function

[5] Display supply voltage U<sub>1</sub>

[6] Display changeable voltage U<sub>2</sub>

[7] Phase angle  $\varphi = 0 - 359^{\circ}$ , step 1°

[8] Duration  $t_1 0,1 \text{ ms} - 9980 \text{ ms}$ 

[9] Interruptions / voltage variations synchronous and asynchronous

[10] Inversion of a period

[11] Activation RS 232

[12] RS 232 interface

[13] Setting of phase angle [7], duration [8], period [14] and test time [15] with digital potentiometer

[14]	Periode t	7
נדידן	i ciioac t	2

asynchron.: 5,0 ms - 9990 ms synchron.: 20 ms - 9980 ms

[15] Test duration

0,1 sec - 9990 sec, single event and duration

[16] Trigger: Start / Stop button

[17] Trigger external: BNC - connection

[18] Inrush current i<sub>max</sub> / rated current

measurement

[19] Test sample connection: Schuko socket

[20] Additional laboratory sockets

[21] Earth connection: at front and rear

[22] Memory button

Measurement technology: back side

BNC connectors for voltage, current and trigger

Supply "U<sub>1</sub>": rear side

Supply "U2": rear side (e.g. step transformer)

Options		
VIS 740	Step transformer 16 A for voltage fluctuation	
VIS 760	Diode in a housing, for DC mode with high impedance	

All information regarding appearance and technical data correspond to the current state of development at the time of release of this data sheet. We reserve the right to make technical changes.

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